

Search Notes**Application/Control No.**

10/790,833

Examiner

John A. Tweel, Jr.

Applicant(s)/Patent under Reexamination

KUROSAWA, YUICHI

Art Unit

2636

SEARCHED

Class	Subclass	Date	Examiner
340	636.1	8/19/2005	JAT
320	106	8/19/2005	JAT
	125	8/19/2005	JAT
	126	8/19/2005	JAT
396	301	8/19/2005	JAT
	277	8/19/2005	JAT
	539	8/19/2005	JAT

All classes searched JAT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
340	636.1	8/19/2005	JAT
396	301	8/19/2005	JAT
	539	8/19/2005	JAT